



## Using “Inheriting and Overloading” concept in creating reusable universal test method library

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### Introduction

Test method is a critical software component in the V93000 test program. For a determined test condition and instrument, the test procedure, which is implemented with test method, is highly reusable. This article introduces how to build a reusable but customizable universal test method (UTM) library.

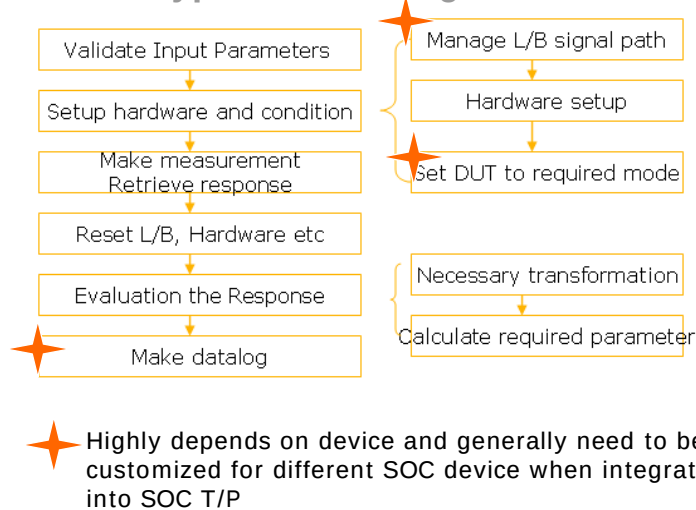
The basic idea is to leverage the “design pattern” concept in software engineering. A “design pattern” is a general reusable solution to a commonly occurring problem in software design. A “design pattern” is a description or template on how to solve a problem that can be reused in many different situations. Carefully studying the test procedure of a mixed signal or RF IP block, we can find that the procedure fits some “pattern” so that the “design pattern” concept can be leveraged in creating test method.

### Template method Pattern Introduction

This article will introduce one pattern to handle specific issues that happen when developing a kind of TM code in the V93000. Sometimes test engineers want to specify the order of operations of some kind of test, such as a general RF test, but allow variation for their own implementations of some of the steps. A general mixed signal and RF test “design pattern” can be described as the following diagram, and we can use the “template method pattern” in implementing the test method.

## Customizable Testmethod

### Flow of a typical Mixed Signal Test



(Figure 1: the pattern of a general mixed signal or RF test)

The Template Method pattern is a fundamental technique for code reuse.

It defines the skeleton of an algorithm in one test, deferring some steps (e.g., “manage L/B signal path, Hardware setup” etc) to subclasses. Template Method, which is implemented with a C++ class, lets subclasses redefine certain steps of an algorithm without changing the algorithm's structure.

With C++ programming, first a class is created that provides the basic steps in the “template method pattern”. These steps are implemented using methods. Later on, subclasses change the methods in parent class to implement real actions. Thus the general Task is saved in one place but the concrete steps may be changed by the subclasses. The template method thus manages the larger picture of test semantics, and more refined implementation details of selection and sequence of methods.

This larger picture calls abstract and non- abstract methods for the test at hand. The non-abstract methods are completely controlled by the template method but the abstract methods, implemented in subclasses, provide the pattern's expressive power and degree of freedom. Some or all of the abstract methods can be specialized in a subclass, allowing the writer of the subclass to provide particular behavior with minimal modifications to the larger semantics.

The template method (which is non-abstract) remains unchanged in this pattern, ensuring that the subordinate non-abstract methods and abstract methods are called in the originally-intended sequence.

The template method pattern is very useful in TM development especially for:

1. Let subclasses implement (through method overriding) behavior that can vary behavior to fit a dedicated DUT, loadboard and test requirement;
2. Avoid duplication in the code: localize common behavior (e.g., start sequencer, data uploading, etc.) among subclasses and place it in a common class (in this case, a super class). In other words, the test engineer can focus on DUT, loadboard and

waveform processing stuff, instead of those instrument relevant activities; Those instrument relevant activities in common class (super class that is finally delivered as a shared library) can be easily upgraded while not changing the code in subclass;

3. The best practice (e.g., SmartCalc framework, suitable use of "FLUSH" etc.) can be placed in a common class, so that high efficient test program can be expected;
4. Control at what point(s) sub-classing is allowed. As opposed to a simple polymorphic override, where the base method would be entirely rewritten allowing radical change to the workflow, only the specific steps/details of the workflow are allowed to change;

In a template method, the parent class calls the operations of a subclass and not the other way around. This is an inverted control structure that's sometimes referred to as "the Hollywood principle," as in, "Don't call us, we'll call you".

There is basic C++ knowledge used in the above pattern.

Inheritance lets the developer define classes that model relationships among types, sharing what is common and specializing only that which is inherently different. Members defined by the base class are inherited by its derived classes. The derived class can use, without change, those operations that do not depend on the specifics of the derived type. It can redefine those member functions that do depend on its type, specializing the function to take into account the peculiarities of the derived type. Finally, a derived class may define additional members beyond those it inherits from its base class.

Virtual functions overcome the problems with the type-field solution by allowing the programmer to declare functions in a base class that can be redefined in each derived class. Virtual functions can be used to define different behavior dynamically during TM executing.

```
class Animal {
public:
    virtual void eat() const {
        std::cout << "I eat like a generic Animal." << std::endl;
    }
    virtual ~Animal() {
    }
};

class Wolf : public Animal {
public:
    void eat() const {
        std::cout << "I eat like a wolf!" << std::endl;
    }
    virtual ~Wolf() {
    }
};

std::vector<Animal*> animals;
animals.push_back(new Animal());
animals.push_back(new Wolf());
for (std::vector<Animal*>::const_iterator it = animals.begin(); it != animals.end(); ++it) {
    (*it)->eat();
    delete *it;
}
```

Output with the virtual function Animal::eat():

```
I eat like a generic Animal.
I eat like a wolf!
```

Output if Animal::eat() were not declared as virtual:

Output if Animal::eat() were not declared as virtual:

```
I eat like a generic Animal.
I eat like a generic Animal.
```

(Figure 2, an example of C++ inheritance, overloading and virtual function)

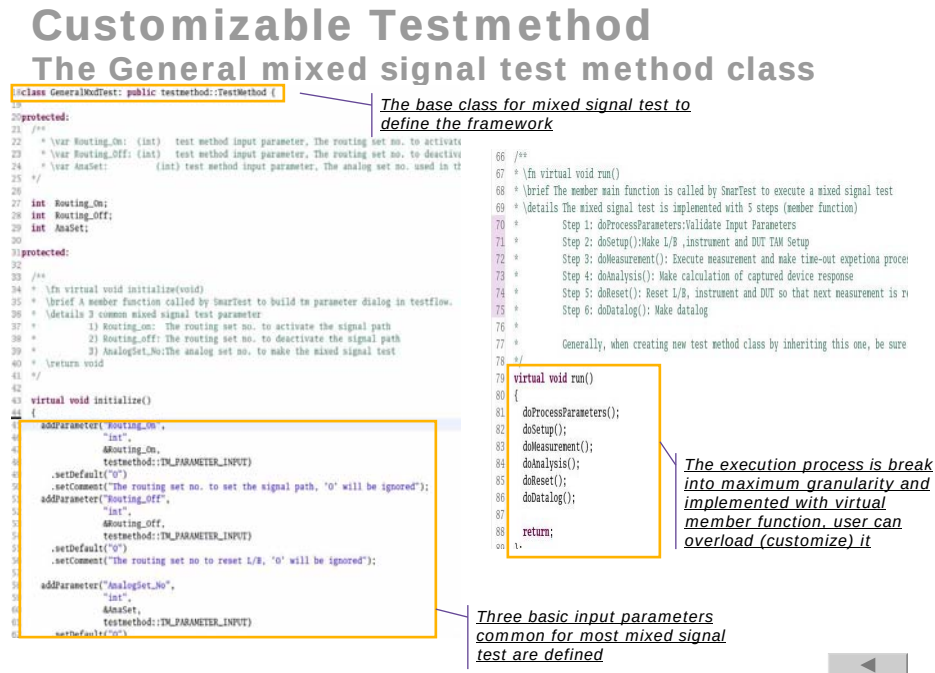
The introduction of self-contained, registration free "Unified Test Method" since SMT 6.1 provides a powerful tool in implementing the above concept. First of all, the new style test

method is just a C++ class and the developer can use inheritance or overloading methods to refine any steps in the run () function but not touch the source code. The customization can effectively handle the diversity of routing setup, analysis algorithm, datalog, etc.

## The hierarchy structure of a test method library

In the following section, we introduce how to build a comprehensive test method step by step by inheriting a father class in the library.

Figure 3 is the base class GeneralMxdTest, which is the implementation of the mixed signal test “template method pattern” as shown in Figure 1.



(Figure 3)

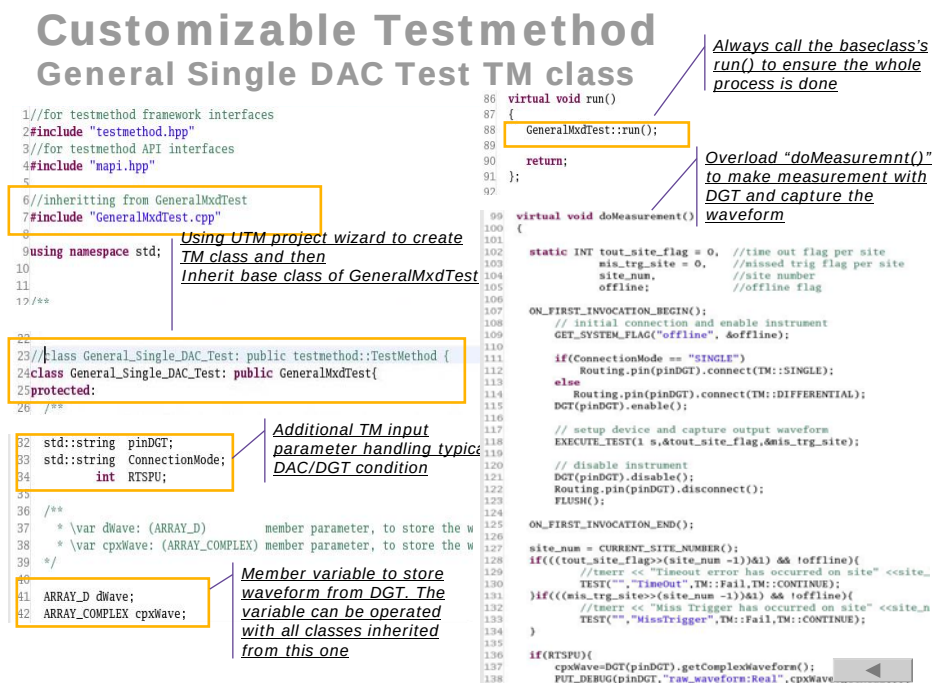
C++ virtual function is defined and used in the “run()” that is actually invoked by SmartTest to execute a test. The “execution” process is broken into maximum granularity so that if necessary, the developer can re-define any virtual member function in the child class.

In fact, in the base class, we don’t actually define any virtual function and just provide a framework. Developers can overload that virtual function according to their requirements in the child class.

1. doProcessParameters(): Validate input parameter;
2. doSetup():
  - a. Instrument\_Setup(): setup analog module and all other modules, analog setup can be called here or with API to program analog module (smarTest 6.5);
  - b. TAM\_Setup(): Setup the DUT to a test mode, a general case is to invoke protocol transaction API to modify a pattern and then run the pattern to setup registers;
  - c. LB\_Routing\_Setup(): call a routing setup or with API to manage the signal path on the loadboard.

3. doMeasurement(): Execute the test, make exceptional error processing (e.g. timeout, no trigger etc.) and then retrieve captured response to workstation
4. doAnalysis():
  - a. Data\_Transform(): Make necessary transformation of captured waveform etc.
  - b. DSP\_Calc(): Calculate required result;
5. doReset(): Reset loadboard, analog module, etc. and make them ready for next measurement;
6. doDatalog(): Make datalog.

Figure 4 illustrates inheriting the GeneralMxdTest to create a general class for single DAC test, the key overloading is as the virtual function “doMeasurement”, in which a general single digitizer operation is implemented.



(Figure 4)

Figure 5 illustrates the process of creating a test method for a specific DAC noise testing, by inheriting the General DAC test class General\_Single\_DAC\_Test. The key overloading here is the virtual function “Instrument\_Setup” and “DSP\_Calc”. In the function Insturement\_Setup(), we coded the DGT setup (e.g., sample rate, etc. that is necessary to make the DAC noise measurement); while the overloaded function “DSP\_Calc” is to implement the customer defined algorithm in calculating the noise.

## Customizable Testmethod

### TM Class of TestIP RFM Noise Test

```
#include "General_Single_DAC_Test.cpp"
7
using namespace std;
9
10/**
11* Testmethod class.
12*
13* For each testsuite using this testmethod, one object of this
14* class is created.
15*/
16class RFM_NOISE: public General_Single_DAC_Test {
17protected:
18    double Freq;
19
20
21
22
23    DOUBLE Fs,Fc; //sample rate and center frequency of IFDGT
24
25    DOUBLE pwr_noise_1M;
26    DOUBLE freq_spur_1M;
27    DOUBLE freq_fund;
28    DOUBLE pwr_fund;
29
30protected:
31    /**
32     * Initialize the parameter interface to the testflow.
33     * This method is called just once after a testsuite is created.
34     */
35    virtual void initialize()
36    {
37        General_Single_DAC_Test::initialize();
38        addParameter("Frequency_of_Test_Signal",
39                    "double",
40                    &Freq,
41                    testmethod::TM_PARAMETER_INPUT)
42    }
```

Add additional parameter "Freq" but always call baseclass's "initialize()" function so that base TM's input parameters will be inherited

```
virtual void Instrument_Setup()
{
    //Get the fs: sample rate and fc: Center frequency
    Fs = ANALOG(AnaSet).DGT(pinDGT,1).getFrequency();
    if(RTSPU) Fc = ANALOG(AnaSet).DGT(pinDGT,1).getCenterFrequency();
};
```

Overloading DSP\_Calc to make calculation according requirement

```
virtual void DSP_Calc()
{
    cout << "The sample frequency is " << Fs << endl;
    if(RTSPU) cout << "The center frequency is " << Fc << endl;
    //The captured waveform is stored as cpxWave;
    //Calculate spectrum
    ARRAY_D spectrum;
    DSP_RF_SPECTRUM(cpxWave,spectrum,RECT,0); //the unit is dBm
    PUT_DEBUG(pinDGT,"Spectrum in dBm",spectrum);
    // Looking for signal bin
    INT sample_pts=cpxWave.size();
    DOUBLE min,max;
    INT min_bin, max_bin;
    DSP_MINMAX(spectrum, &min, &max, &min_bin, &max_bin);
    //Determine the frequency shift to center frequency;
    freq_fund = Fc+(max_bin-sample_pts/2)*Fs/sample_pts;
    cout << "The bin of max signal is shift to IF as:" << max_bin
    << "The center frequency is:" << Fc
    << "Then the test signal frequency is(MHz): " << freq_fund/1e
    //SUM max_bins/-3 power
    DOUBLE fund = pow(10,spectrum[max_bin-3]/10)+
    pow(10,spectrum[max_bin-2]/10)+
    pow(10,spectrum[max_bin-1]/10)+
    pow(10,spectrum[max_bin ]/10)+
    pow(10,spectrum[max_bin+3]/10)+
    pow(10,spectrum[max_bin+2]/10)+
    pow(10,spectrum[max_bin+1]/10)+
    pow(10,spectrum[max_bin]/10);
    cout << "The test signal power is (dBm): " << 10*log10(fund) << endl;
}
```

(Figure 5)

The final test method class to execute an RFM DAC noise measurement is in figure 6. To implement the noise test of an RFM DAC in an SOC, we need to make a suitable LB connection, as overloading the virtual function "LB\_Routing\_Setup". Another necessary setup is to control the DUT suitable for the RFM DAC testing, and this is implemented by overloading the virtual function TAM\_setup().

## Customizable Testmethod

### TM class of device specific RFM noise test

```
7#include "RFM_NOISE.cpp"
8
using namespace std;
10
11/**
12* Testmethod class.
13*
14* For each testsuite using this testmethod, one object of this
15* class is created.
16*/
17class RFM_Test_X: public RFM_NOISE {
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```

Inheriting base TM of the TestIP RFM Noise Test

Overload LB\_Routing\_Setup() that are L/B specific to manage the signal path on L/B

```
virtual void LB_Routing_Setup()
{
    ON_FIRST_INVOCATION_BEGIN();
    Routing.util("K32,K33").off();
    Routing.util("K31").on();
    ON_FIRST_INVOCATION_END();
}

virtual void LB_Routing_Reset()
{
    ON_FIRST_INVOCATION_BEGIN();
    Routing.util("K32,K33").off();
    Routing.util("K31").off();
    ON_FIRST_INVOCATION_END();
}
```

```
59 virtual void TAM_Setup()
60 {
61     PFMU_SETTING PLLCAP_setting;
62     PFMU_RELAY relay_close, relay_open;
63     PFMU_MEASURE PLLCAP_meas;
64     TASK_LIST PLLCAP_task;
65
66     ON_FIRST_INVOCATION_BEGIN();
67     double dVolts = 0;
68
69     //*****power on step*****
70     while(dVolts < 2.35)
71     {
72         Primary.getLevelSpec().change("avdd_2v5", dVolts V);
73         dVolts += 0.025;
74         if(dVolts > 2.35)
75         {
76             Primary.getLevelSpec().change("avdd_2v5", 2.5*0.94 V)
77         }
78     }
79
80     ON_FIRST_INVOCATION_END();
81
82     //*****power off step*****
83     while(dVolts > 2.35)
84     {
85         Primary.getLevelSpec().change("avdd_2v5", dVolts V);
86         dVolts -= 0.025;
87         if(dVolts < 2.35)
88         {
89             Primary.getLevelSpec().change("avdd_2v5", 2.5*0.94 V)
90         }
91     }
92
93     ON_FIRST_INVOCATION_END();
94 }
95
96 virtual void doDatalog()
97 {
98     string testname;
99     LIMIT lim;
100     double val;
101     int testnumber=702001;
102     string prefix;
103
104     if(Freq == 67.25) prefix="RFM6725_";
105     if(Freq == 61.25) prefix="RFM6125_";
106     testname=prefix+"PLLVDD";
107     lim.low(TM::GT,1.07); lim.high(TM::LT,1.33); lim.unit("V");
108     val=RFM_PLLVDD;
109     if( TESTSET().cont(GlobalOverOn).testnumber(testnumber++).judgeAndLog_Pe
110         cout << testname << ": " << val << "\t PASS" << endl;
111     }
112     else cout << testname << ": " << val << "\t FAIL" << endl;
113 }
```

Overload TAM\_Setup to setup device specific test mode.

Overload doDatalog to make formatted datalog

(Figure 6)

## **Conclusion**

The introduction of UTM opens the door to using some object oriented programming methods, such as “design pattern”, “inheritance and overloading,” etc. in test method programming. With this software method, we can build reusable and easy-to-customize test methods efficiently.